PROCEEDINGS OF SPIE

Optical Modeling and Performance Predictions XII

Mark A. Kahan Editor

22 August 2022 San Diego, California, United States

Sponsored and Published by SPIE

Volume 12215

Proceedings of SPIE 0277-786X, V. 12215

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

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Please use the following format to cite material from these proceedings: Author(s), "Title of Paper," in *Optical Modeling and Performance Predictions XII*, edited by Mark A. Kahan, Proc. of SPIE 12215, Seven-digit Article CID Number (DD/MM/YYYY); (DOI URL).

ISSN: 0277-786X

ISSN: 1996-756X (electronic)

ISBN: 9781510654143

ISBN: 9781510654150 (electronic)

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA Telephone +1 360 676 3290 (Pacific Time) SPIE.ora

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